



Beam Commissioning and Characterization of the CLIC Stripline Kicker at ALBA

U.Iriso, G. Benedetti, T. Guenzel, Z. Martí, F. Pérez, M.Pont (ALBA) M. Barnes, M. Carla, J. Holma, I. Papaphilopous (CERN)





Workshop on "Beam Tests and Commissioning of Low Emittance Rings" 2019/02/19 – Karlsruhe (Germany)

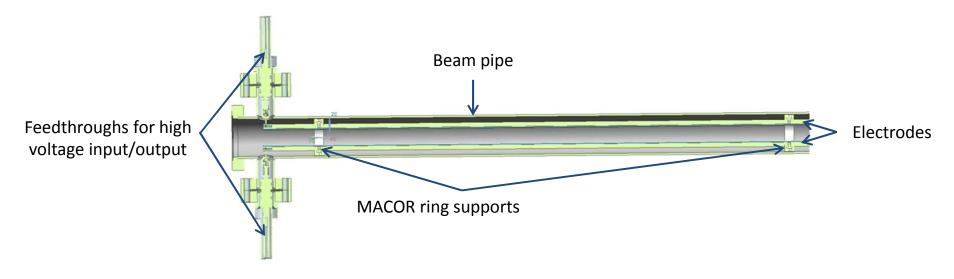


- Introduction
- Installation
- Stripline Characterization with Beam:
 - DC Kick using HV PS
 - AC Kick Inductive Adders
- Transverse Impedance Measurements
- Conclusions



Introduction

- The Extraction Kicker at CLIC Damping Rings needs to provide very stable kicks to guarantee Luminosity in a Bunch-by-Bunch collision rate
- For this purpose, a special Stripline Kicker was designed[*] and manufactured [**]
 with very stringent requirements
- ALBA signed an agreement signed with CERN to characterize the stripline with beam at ALBA Storage Ring



[*] C. Belver-Aguilar et al, Beam impedance study of the stripline kicker for the CLIC damping ring, Proc. IPAC 2012 [**] Vacuum Trinos S.L., Valencia (Spain)



Introduction

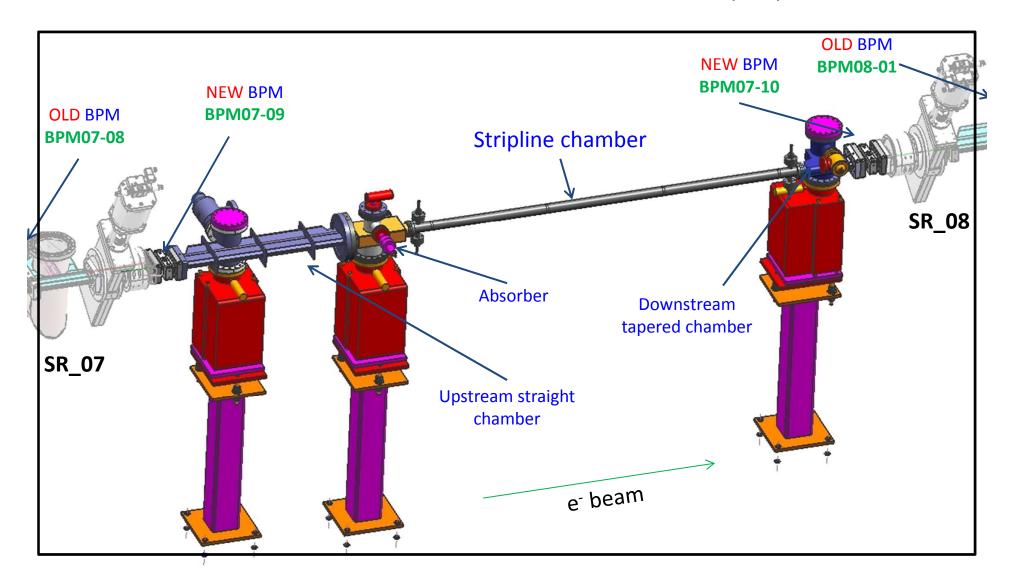
Requirements for the Extraction Kicker at CLIC

CLIC Stripline parameters			
Kick angle, mrad	1.5		
Effective length, m	1.7		How this precision can bachieved and measured within this region??
Good Field Region, mm	±1		
Field homogeneity	±2·10 ⁻⁴		
Flat top reproducibility	±1·10 ⁻⁴		within this region::
Pulse rise & fall time, ns	100		
Pulse flat top, ns	160 - 900		



Installation

Besides the stripline, the beam characterization required also to design & install **2 additional BPMs**, absorbers and transition chambers , vacuum pumps...

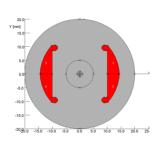


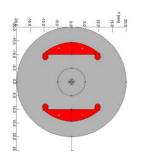


Installation: some issues...

Stripline kicker designed to extract beams in the hor plane

Rotate the stripline by 90° to avoid limit horizontal aperture

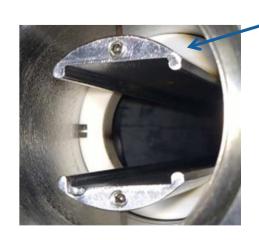


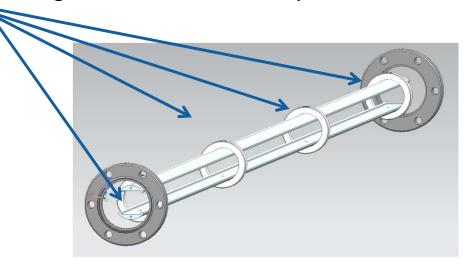


CLIC Configuration

ALBA Operation

Al Electrodes Length=1.7m, holded by MACOR rings for mechanical stability

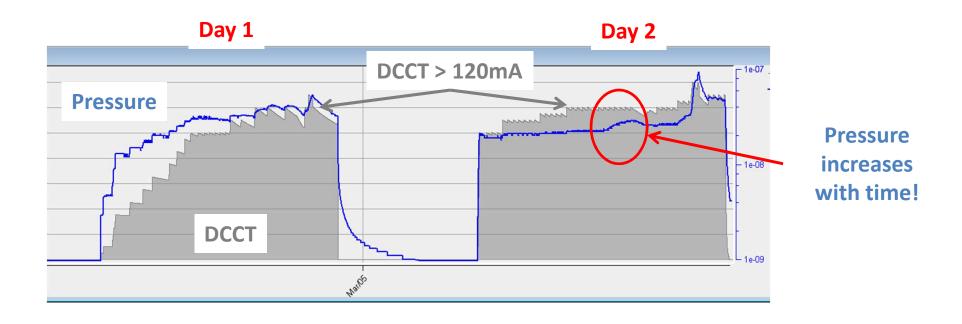






<u>Installation – Try 1</u>

The stripline (outgassing) behaviour for large currents limited machine operation We had to install & uninstall everytime for the measurements!



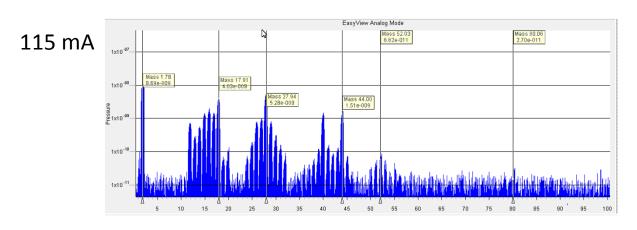
- For DCCT < 120mA, pressure is slowly decreasing, OK
- For DCCT > 120mA, pressure run away, **NOK**

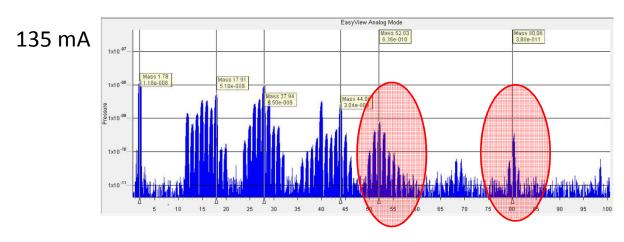
Stripline removed to guarantee machine operation for users at 180mA



<u>Installation – Try 1</u>

RGA data to analyse pressure increase





Strange peaks appear: 52 (Cr) and 80 (Br) ion trapping? SR hitting MACOR rings? desorption due to image currents at electrodes?

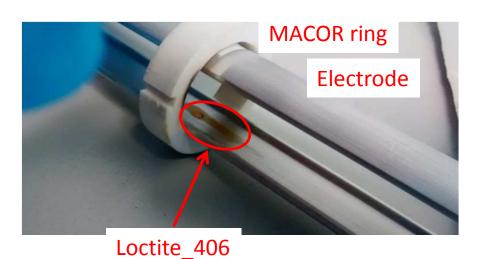


<u>Installation – Try 1 Conclusions</u>

When removing and opening the stripline, realized two dangerous things:

- Synchrotron Radiation might be hitting the MACOR rings
- Manufacturer used Loctite_406 to fix the screws at the electrodes



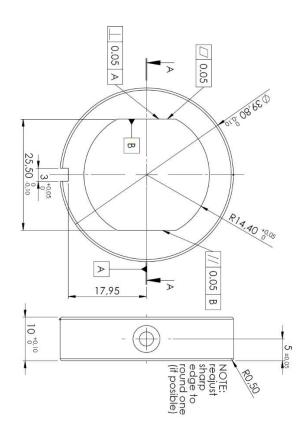




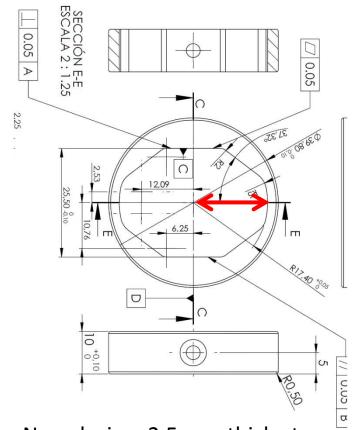
<u>Installation – Try 1 Conclusions</u>

New Installation:

- remove Loctite_406 from electrodes
- trim MACOR rings to enlarge horizontal clearance



Original design, 5.5 mm thick all around

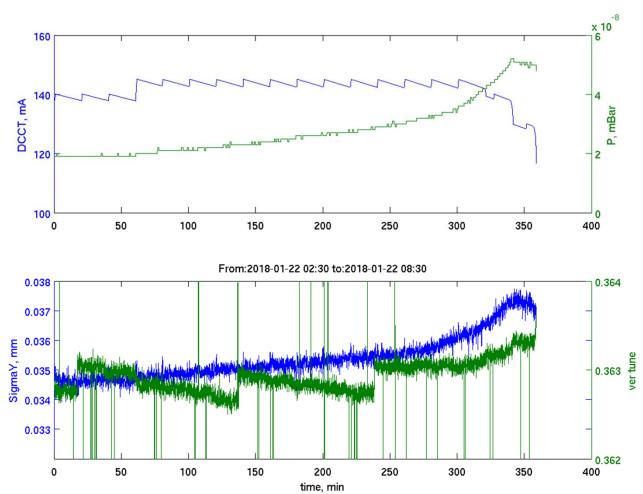


New design, 2.5 mm thick at synchrotron radiation plane



Installation 2.0

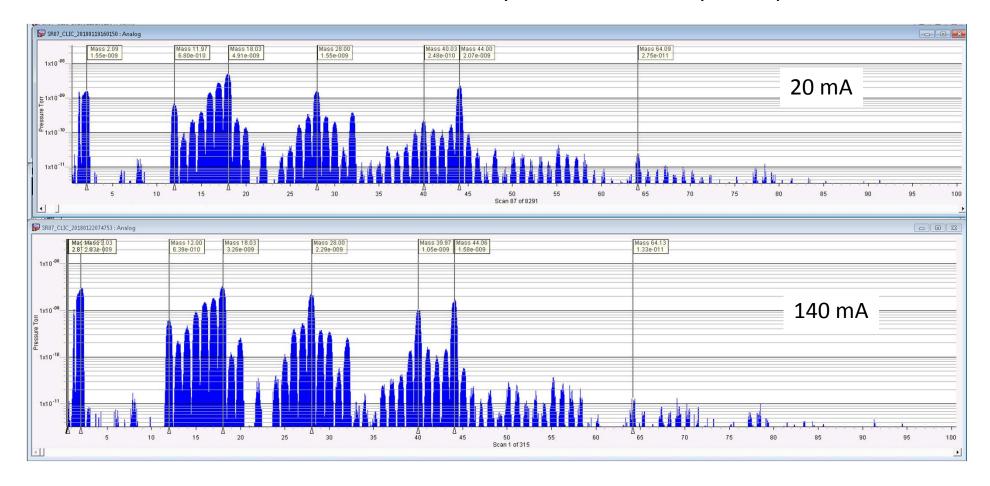
Nevertheles... similar behaviour, but this time at 140mA We also look at tunes and beam size, which pointed out towards ion trapping effects





Installation_2.0

However, this time RGA analysis did not show any weird peaks



CONCLUSIONS

To guarantee machine operation at 180mA, remove stripline Decided to install & uninstall every time to test the stripline with (low current) beams



Stripline Characterization with Beam

Sep. 2018 (installed during 4 days)

- Transverse Field Homogenety DC HVPS
- Transverse Beam Coupling Impedance

Jan. 2019 (installed during 5 days)

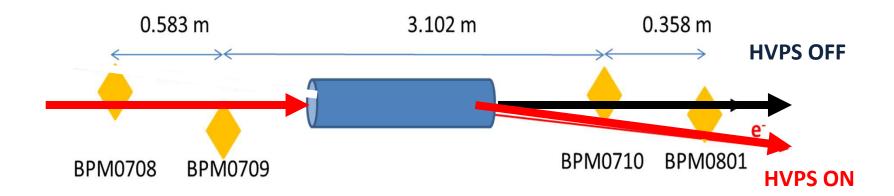
- Longitudinal Pulse Homogeneity (Inductive Adder)
- Longitudinal Beam Coupling Impedance (incomplete)

<u>Stripline Transverse Field Homogeinety – DC HVPS</u>

Measurements with the HV DC power supplies:

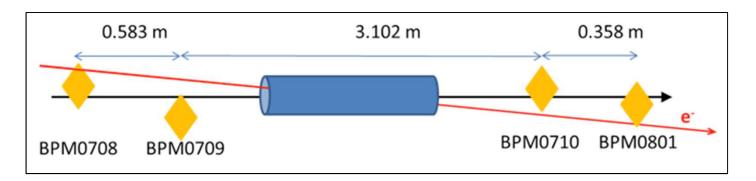
- Commissioning: stripline sparked a lot with beam, and it took ~2days to reach +/-10kV and 13mA beam!
- Local Angle Measurement using 4 BPMs

$$\alpha = \frac{y_4 - y_3}{d_{4-3}} - \frac{y_2 - y_1}{d_{2-1}}$$





<u>Stripline Transverse Field Homogeinety – DC PS</u>

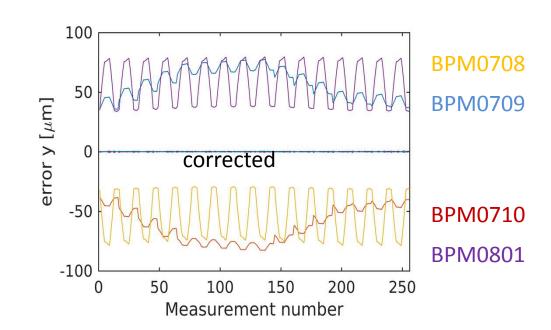


BPM Calibration (Stripline off)

Measurement precision improved if BPM precision improves

With the stripline off, the position along 4 consecutive BPMs should follow a straight line.

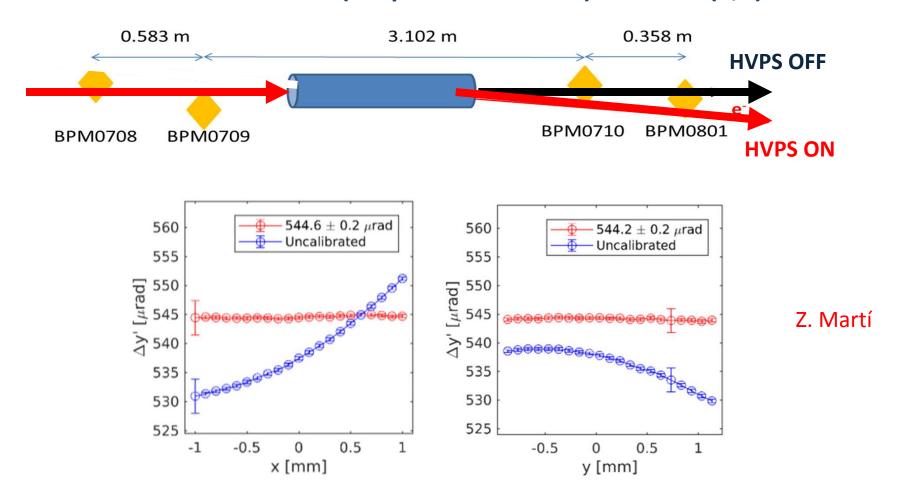
We did bumps along +/1mm, and used the data to fit the BPMs offsets, gains, & rolls that minimize the discrepancies





Stripline Transverse Field Homogeinety – DC PS

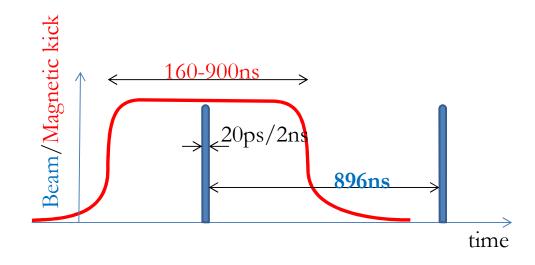
Measurements (Stripline on @10kV) around ±(1,1)mm



Effective kick at ±10kV: 544.4±0.2 μrad (theoretically, 560 urad)

 \rightarrow Homogeneity of 3.7·10⁻⁴ ±5.3·10⁻⁴ (compatible with CLIC requirements <2·10⁻⁴)

Measurements: Field flat-top stability and pulse-pulse repeatability

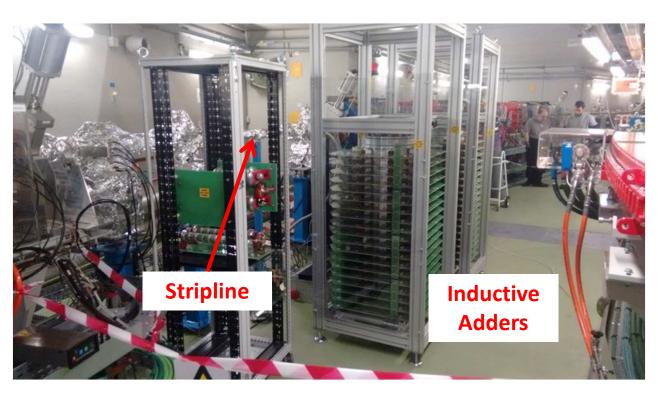


- Measurements in single bunch: scan the pulse-bunch delay along the pulse flat-top
- Vary pulse width (160 900)ns and delay
- Use global amplitude with all 120 BPMs, TBT data (500 turns), and with enough averaging (50 shots) to reach required precision (1e-4)



Lab Tests and Installation @ALBA

- HV (10kV) pulse of length [160 900]ns performed with Inductive Adders
- Long cables might distort the pulse. To avoid it, the inductive adders were installed inside the ALBA tunnel
- Both the stripline and Inductive Adders were removed after the tests





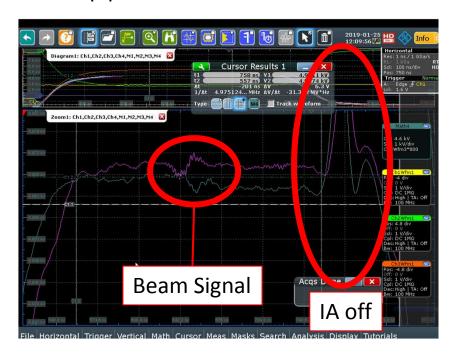


Measurements with Beam

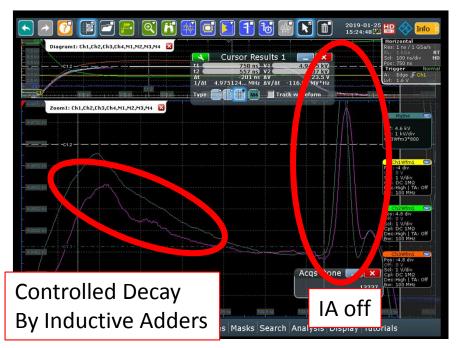
Inductive Adders able to produce an overpulse with slow decay[*], so that the beam can see a flat kick (flat total combination of electric and magnetic fields – see [**])

Reached homogeneity of +/-0.02%

Flat-top pulse



Decay Signal pulse



- [*] J. Holma, The Prototype Inductive Adder With Droop Compensation for the CLIC Kicker Systems, IEEE Transaction of Plasma Science, Oct. 2014
- [**] C. Belver-Aguilar, "Transient Studies of the Stripline Kicker for Beam Extraction from CLIC Damping Rings", in Proc. IBIC'16, Barcelona, Spain (2016)

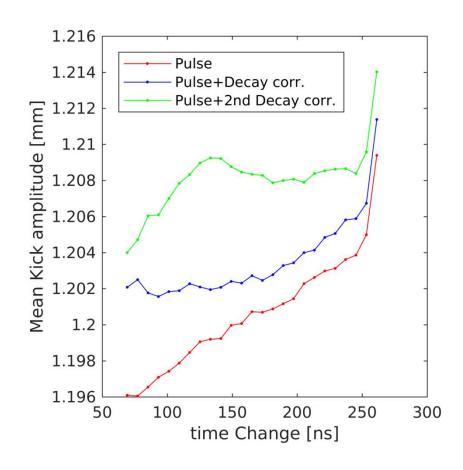


Measurements with Beam

Z. Martí and J. Holma

The strip-line kick at **2x5kV** with a 160ns flat-top is measured with different timing delays.

The pulser unit compensation works as expected and pulse correction droop was successfully tested





Longitudinal field homogeneity – Inductive Adders

Measurements with Beam

If we only take the TbT data RMS of (or amplitude at the tune line), the kick seems to vary with time following the beam current decay.

1.25
1.24

WE 1.23

1.29

1.20

1.19

1.18

2.4

2.6

2.8

3

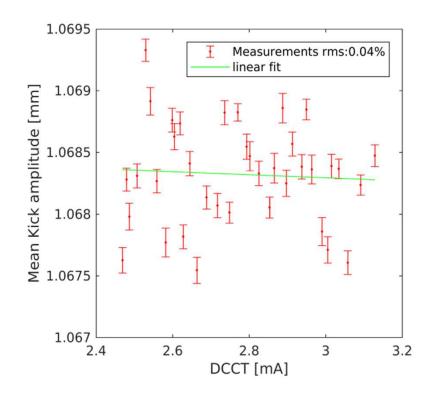
3.2

DCCT [mA]

If the decoherence effect is compensated, we can see how the current dependence disappears.

Single Meas: 0.01%

Average Variation: 0.04%

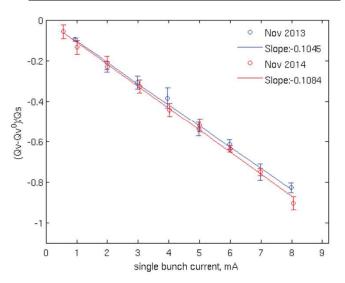


Transverse Impedance Measurement

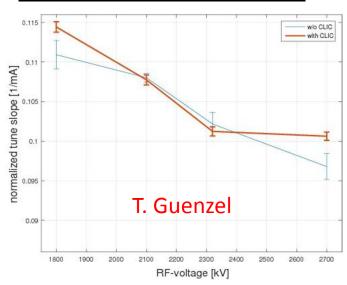
Strategy 1: Measuring the transverse impedance of the total ring before and after the installation of the striplines.

Single bunch measurements to determine TMCI threshold and detuning slope. (Data taken at $\xi V=0$ and different Vrf).

Example of TMCI measurement



Summary with vs w.o. CLIC SL



Very noisy, probably due to machine repeatibility. But consistent with expectations:

Measured Impedance: $(\beta Z)_{eff} = 11.6 \text{ k}\Omega$

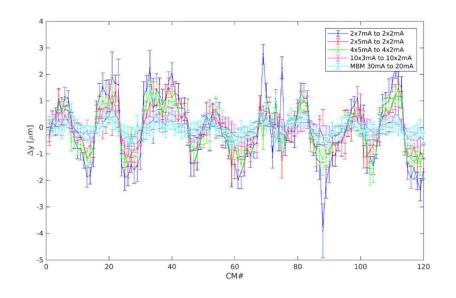
From Gdfidl simulations: $(\beta Z)_{eff} = 11 + / - 12 k\Omega$

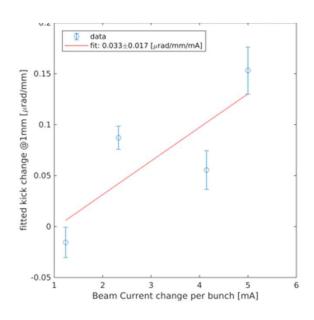


Transverse Impedance Measurement

Strategy 2: Local Bump

- 1. Produce a vertical bump of y_0 at the SL location (+/-1mm)
- 2. Get orbit at high beam current, I_H (8 mA/bunch, limited by beam instabilities)
- 3. Scrape down the beam until a "low" beam current is reached I₁ (min of 1mA/bunch)
- Get orbit at low beam current
- 5. The difference between the orbits at 2) and 4) is due to the impedance of the SL





Measured Impedance Kick: Kick from Gdfidl simulations: 0.033±0.017 μrad/mm/mA 0.0244 μrad/mm/mA



SUMMARY & CONCLUSIONS

Beam characterization has been done by installing the Stripline several times Although his limited the time for experiments a lot, a full characterization has been carried out:

- Vacuum Conditioning: could not reach beam currrents >140mA w.o. compromising machine operation (within the scheduled time)
- ✓ Transverse Field Homogeneity HV DC tests
- Longitudinal Field Homogeneity Inductive Adder
- ✓ Transverse Beam Coupling Impedance

PLAN WELL YOUR MEASUREMENTS!

Example: transverse field homogeneity of 2e-4 was achieved thanks to the installation of 2 additional BPMs





Thanks!



EXTRA-SLIDES



Measurement set up

Possible Field homogeneity techniques:

Power supply	Technique	Measurement limit	Comments
DC	COM (closed orbit measurement)	Trv. Homogeneity 1%	No additional hardware
	LOM (local orbit measurement)	Trv. Homogeneity 0.01%	Additional standard hardware
Pulsed	SBTOM (single bunch TbT orbit measurement)	Trv. Homogeneity 1% Lg. Homogeneity 0.01%	No additional hardware. Systematic error around around 1%. Pulse Repeatability mixed with homogeneity.
	SPLOM (single pass local orbit measurement)	Trv. Homogeneity 0.01%? Lg. Homogeneity 0.01%?	Additional non standard hardware.



MACOR

MACOR® Machinable Glass Ceramic

- is MACHINABLE with ordinary metal working tools
- allows FAST TURNAROUND, no post firing required
- holds TIGHT TOLERANCES, up to .0005"
- withstands HIGH TEMPERATURE, up to 1000°C (no load)
- · is CLEAN, no outgasing and zero porosity

Composition

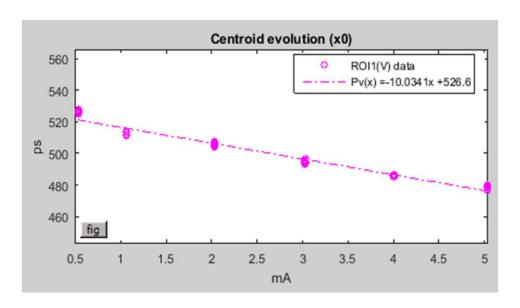
MACOR Machinable Glass Ceramic is a white, odorless, porcelain-like (in appearance) material composed of approximately 55% fluorophlogopite mica and 45% borosilicate glass. It has no known toxic effects; however, the dust created in machining can be an irritant. This irritation can be avoided by good housekeeping and appropriate machining techniques. The material contains the following compounds:

	Approximate Weight %
Silicon - SiO ₂	46%
Magnesium - MgO	17%
Aluminum - Al ₂ O ₃	16%
Potassium - K ₂ O	10%
Boron - B ₂ O ₃	7%
Fluorine - F	4%



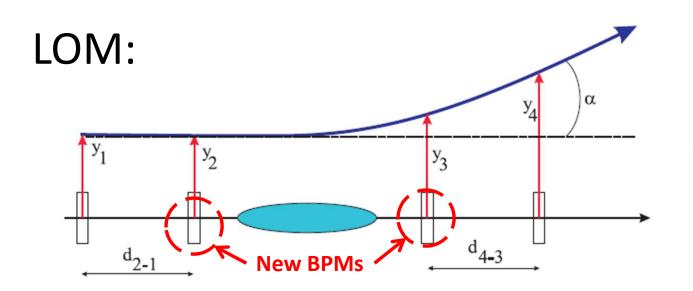
Longitudinal Impedance Measurement

- Measured from the **difference between the global longitudinal** machine measurements with the Stripline **IN and OUT** of the Storage Ring.
- Global longitudinal impedance measured from the phase variation in the streak camera



Limited by machine repeatibility and jitters

Measurement set up



$$\alpha = \frac{y_4 - y_3}{d_{4-3}} - \frac{y_2 - y_1}{d_{2-1}}$$

Relative Uncertainty:

$$RU_{MSS} = \frac{\Delta \alpha_{rand}}{\alpha} = 1.3 \times 10^{-3}$$

 $RU_{LSS} = \frac{\Delta \alpha_{rand}}{\alpha} = 0.4 \times 10^{-3}$

A RU of 1e-4 is achieved:

- after ~200 times for MSS
- after ~20 times for LSS

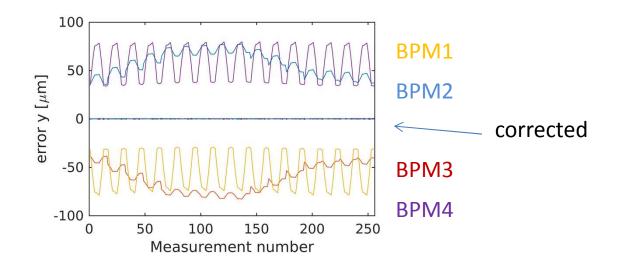
Final BPM position was not optimum. It required **500** measurements to average out the random error.

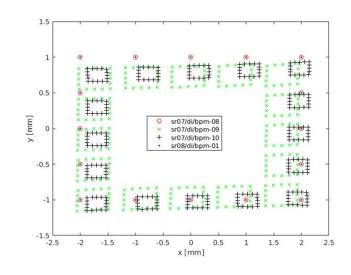


Results: DC calibration

A set of 256 different orbit bumps are produced at the 4 BPMs (1024 measurements, each one an average of) with the strip-line **OFF**.

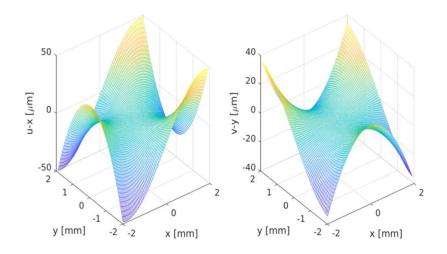
The readings should lay on a straight line, the discrepancy is used to fit their offsets and gains.





Measurement set up

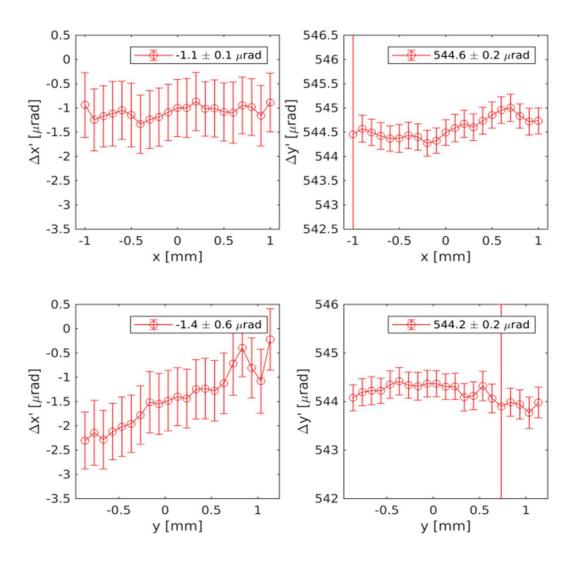
The 4 BPMs offsets, gains and rolls have to be taken into account together with their geometrical non-linear behavior.



With the strip-line installed but OFF, a set of measurements were done in order to take all this into account.



Results: DC



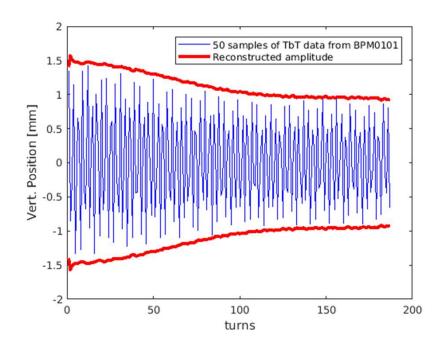
Longitudinal field homogeneity – Inductive Adders

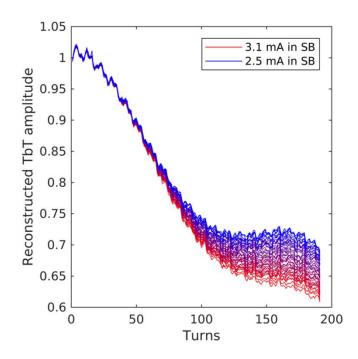
Measurements

Empirically we have seen that the beam current, chromaticity and kick amplitude affect to the beam oscillations decoherence.

The oscillation decoherence affects the observable kick effect, we will need to minimize its effect.

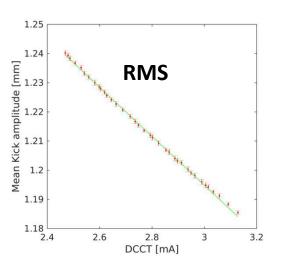
To do that, the TbT oscillations are compensated with the reconstructed action amplitude:

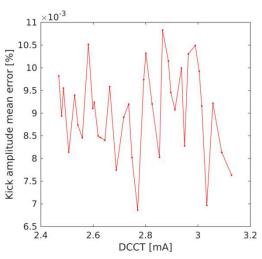






Results: Pulsed





Decoherence compensation

